N-channel TrenchMOS standard level FET

Rev. 03 — 26 January 2009

**Product data sheet** 

## 1. Product profile

### **1.1 General description**

Standard level gate drive N-channel enhancement mode Field-Effect Transistor (FET) in a plastic package using advanced TrenchMOS technology. This product has been designed and qualified to the appropriate AEC standard for use in high performance automotive applications.

### 1.2 Features and benefits

- AEC Q101 compliant
- Avalanche robust

- Suitable for standard level gate drive
- Suitable for thermally demanding environment up to 175°C rating

### **1.3 Applications**

- 12V Motor, lamp and solenoid loads
- High performance automotive power systems
- High performance Pulse Width Modulation applications

### 1.4 Quick reference data

Table 1.	Quick reference						
Symbol	Parameter	Conditions		Min	Тур	Max	Unit
V <sub>DS</sub>	drain-source voltage	T <sub>j</sub> ≥ 25 °C; T <sub>j</sub> ≤ 175 °C		-	-	40	V
I <sub>D</sub>	drain current	$V_{GS}$ = 10 V; $T_{mb}$ = 25 °C; see <u>Figure 1</u> ; see <u>Figure 3</u> ;	[1] [2]	-	-	100	A
P <sub>tot</sub>	total power dissipation	T <sub>mb</sub> = 25 °C; see <u>Figure 2</u>		-	-	333	W
Dynamic	characteristics						
$Q_{GD}$	gate-drain charge	$V_{GS}$ = 10 V; I <sub>D</sub> = 25 A; V <sub>DS</sub> = 32 V; see <u>Figure 15</u>		-	67	-	nC
Static ch	aracteristics						
R <sub>DSon</sub>	drain-source on-state resistance	$V_{GS}$ = 10 V; $I_D$ = 25 A; $T_j$ = 25 °C; see <u>Figure 12</u> ; see <u>Figure 13</u>		-	1.96	2.3	mΩ
Avalance	he ruggedness						
E <sub>DS(AL)S</sub>	non-repetitive drain-source avalanche energy	$      I_D = 100 \text{ A};  \text{V}_{sup} \le 40 \text{ V}; \\       R_{GS} = 50  \Omega;  \text{V}_{GS} = 10 \text{ V}; \\       T_{j(init)} = 25 ^\circ\text{C}; \text{ unclamped} $		-	-	1.2	J

[1] Refer to document 9397 750 12572 for further information.

[2] Continuous current is limited by package.



### N-channel TrenchMOS standard level FET

## 2. Pinning information

Table 2.	Pinning	information		
Pin	Symbol	Description	Simplified outline	Graphic symbol
1	G	gate		-
2	D	drain	mb	
3	S	source		
3 mb	D	mounting base; connected to drain	↓ ↓ ↓ ↓ ↓ ↓ ↓ ↓ ↓ ↓ ↓ ↓ ↓ ↓ ↓ ↓ ↓ ↓ ↓	mbb076 S
			(3-lead TO-220AB; SC-46; SFM3)	

## 3. Ordering information

#### Table 3.Ordering information

Type number	Package					
	Name	Description	Version			
BUK752R3-40C	3-lead TO-220AB; SC-46; SFM3	plastic single-ended package; heatsink mounted; 1 mounting hole; 3-lead TO-220AB	SOT78A			

## 4. Limiting values

#### Table 4.Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions		Min	Max	Unit
V <sub>DS</sub>	drain-source voltage	T <sub>j</sub> ≥ 25 °C; T <sub>j</sub> ≤ 175 °C		-	40	V
V <sub>DGR</sub>	drain-gate voltage	$R_{GS} = 20 \text{ k}\Omega$		-	40	V
V <sub>GS</sub>	gate-source voltage			-20	20	V
I <sub>D</sub>	drain current	$T_{mb}$ = 25 °C; $V_{GS}$ = 10 V; see <u>Figure 1</u> ; see <u>Figure 3</u> ;	[1][2]	-	100	А
		T <sub>mb</sub> = 100 °C; V <sub>GS</sub> = 10 V; see <u>Figure 1</u> ;	[1][2]	-	100	А
		$T_{mb}$ = 25 °C; $V_{GS}$ = 10 V; see <u>Figure 1</u> ; see <u>Figure 3</u> ;	<u>[1][3]</u>	-	276	А
I <sub>DM</sub>	peak drain current	$T_{mb} = 25 \text{ °C}; t_p \le 10 \mu\text{s}; \text{ pulsed}; \text{ see } \frac{\text{Figure } 3}{10 \mu\text{s}}$		-	1104	А
P <sub>tot</sub>	total power dissipation	T <sub>mb</sub> = 25 °C; see <u>Figure 2</u>		-	333	W
T <sub>stg</sub>	storage temperature			-55	175	°C
Tj	junction temperature			-55	175	°C
Source-dr	ain diode					
ls	source current	T <sub>mb</sub> = 25 °C;	[1][3]	-	276	А
		T <sub>mb</sub> = 25 °C;	[1][2]	-	100	А
I <sub>SM</sub>	peak source current	$t_p \le 10 \ \mu s$ ; pulsed; $T_{mb} = 25 \ ^{\circ}C$		-	1104	А
Avalanche	e ruggedness					
E <sub>DS(AL)S</sub>	non-repetitive drain-source avalanche energy	$\label{eq:ID} \begin{array}{l} I_D = 100 \text{ A};  V_{\text{sup}} \leq 40 \text{ V};  \text{R}_{\text{GS}} = 50  \Omega;  \text{V}_{\text{GS}} = 10 \text{ V}; \\ T_{j(\text{init})} = 25 ^{\circ}\text{C}; \text{ unclamped} \end{array}$		-	1.2	J
E <sub>DS(AL)R</sub>	repetitive drain-source avalanche energy	see <u>Figure 4</u> ;	[4][5] [6][7]	-	-	J

[1] Refer to document 9397 750 12572 for further information.

[2] Continuous current is limited by package.

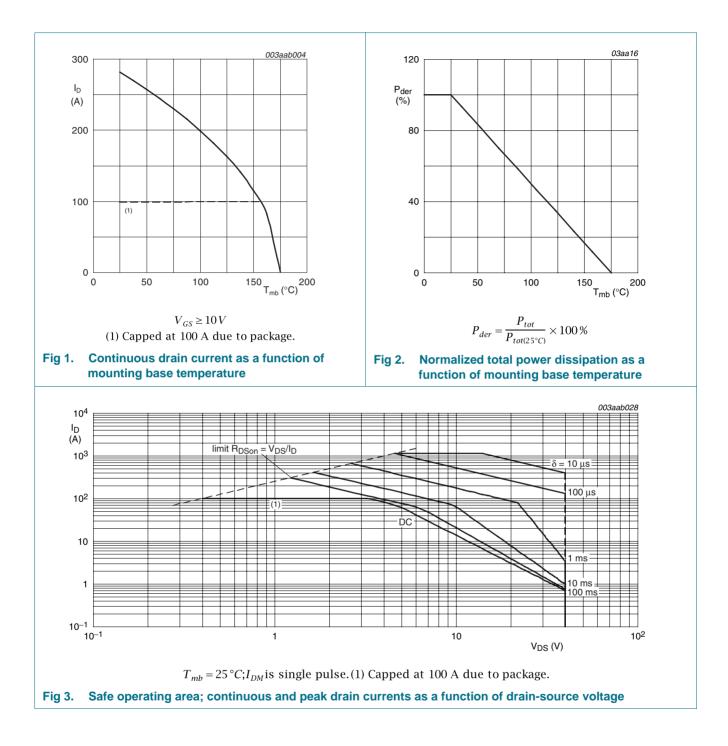
[3] Current is limited by chip power dissipation rating.

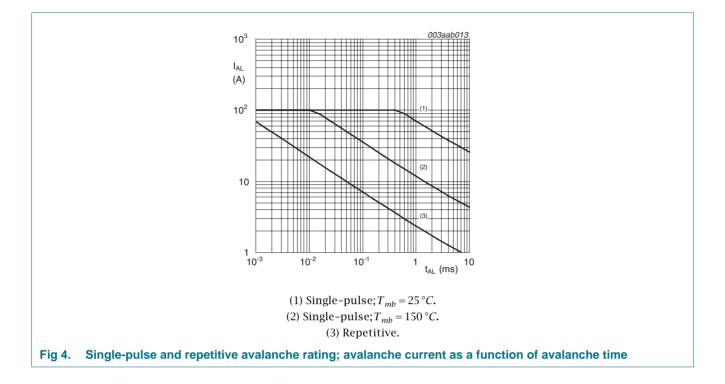
[4] Maximum value not quoted. Repetitive rating defined in avalanche rating figure.

[5] Single-pulse avalanche rating limited by maximum junction temperature of 175 °C.

[6] Repetitive avalanche rating limited by an average junction temperature of 170 °C.

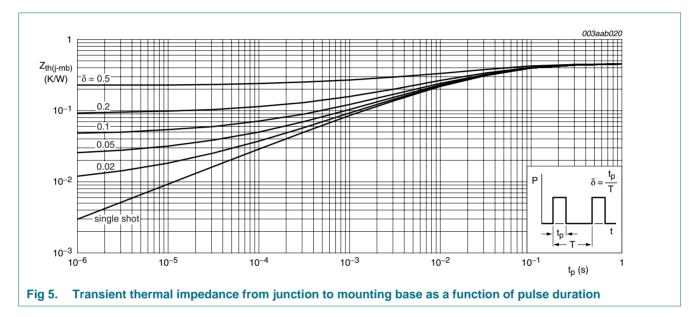
[7] Refer to application note AN10273 for further information.





## 5. Thermal characteristics

Table 5.	Thermal characteristics					
Symbol	Parameter	Conditions	Min	Тур	Max	Unit
R <sub>th(j-mb)</sub>	thermal resistance from junction to mounting base	see <u>Figure 5</u>	-	-	0.45	K/W
R <sub>th(j-a)</sub>	thermal resistance from junction to ambient	Vertical in free air	-	60	-	K/W

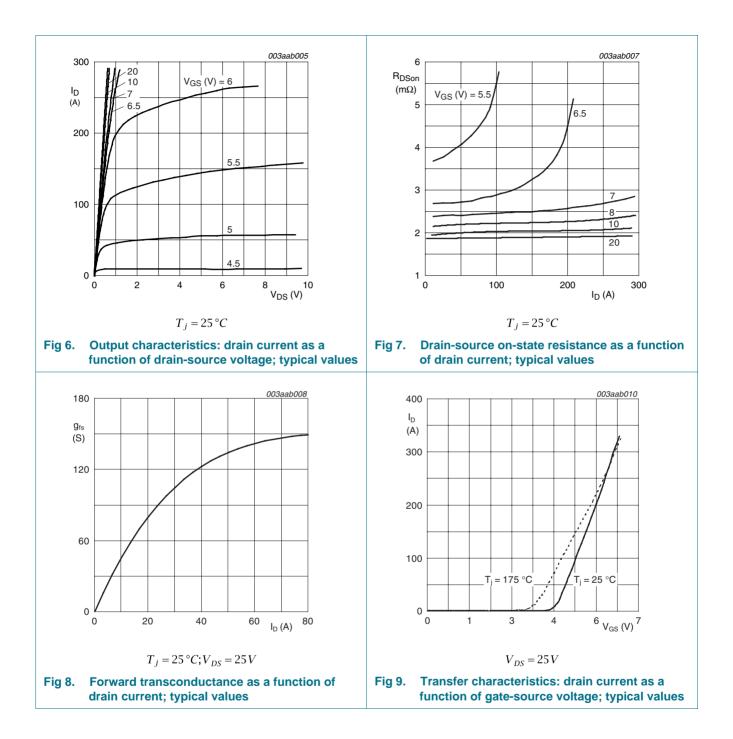


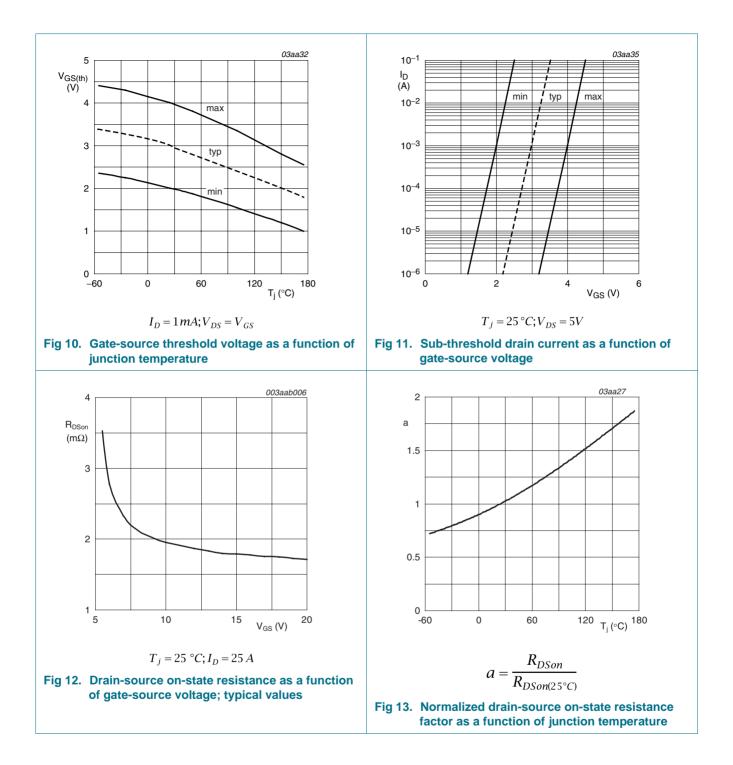
## 6. Characteristics

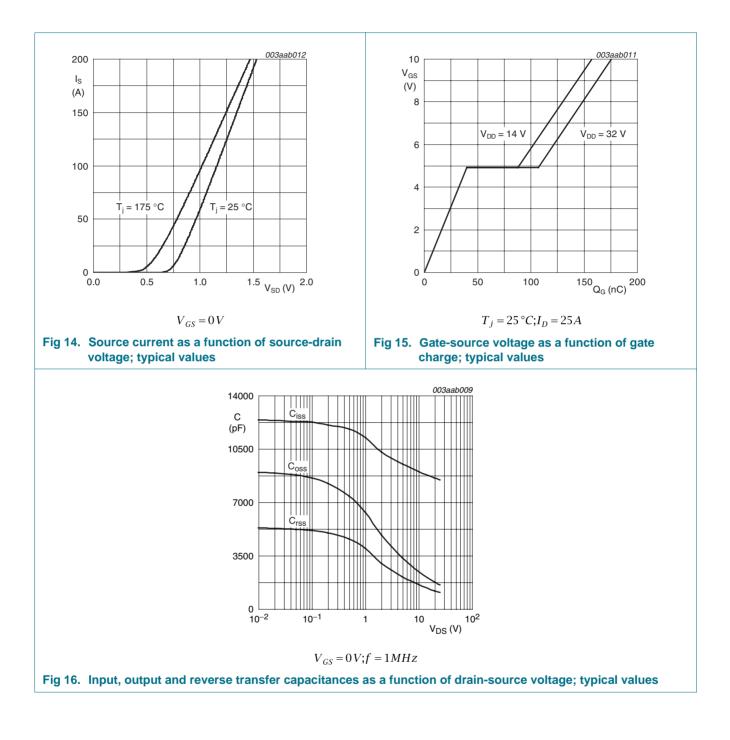
Table 6.	Characteristics	Open dition of		-	N.4	
Symbol	Parameter	Conditions	Min	Тур	Max	Unit
	aracteristics					
V <sub>(BR)DSS</sub>	drain-source breakdown voltage	$I_D = 250 \ \mu A; \ V_{GS} = 0 \ V; \ T_j = 25 \ ^{\circ}C$	40	-	-	V
bleakuowii voltage		$I_D = 250 \ \mu A; \ V_{GS} = 0 \ V; \ T_j = -55 \ ^\circ C$	36	-	-	V
V <sub>GS(th)</sub>	gate-source threshold voltage	$I_D = 1 \text{ mA}; V_{DS} = V_{GS}; T_j = 25 \text{ °C}; \text{ see}$ Figure 10; see Figure 11	2	3	4	V
V <sub>GSth</sub>	gate-source threshold voltage	$I_D = 1 \text{ mA}; V_{DS} = V_{GS}; T_j = -55 \text{ °C}; \text{ see}$ Figure 10; see Figure 11	-	-	4.4	V
		I <sub>D</sub> = 1 mA; V <sub>DS</sub> = V <sub>GS</sub> ; T <sub>j</sub> = 175 °C; see <u>Figure 10</u> ; see <u>Figure 11</u>	1	-	-	V
I <sub>DSS</sub>	drain leakage current	$V_{DS} = 40 \text{ V}; V_{GS} = 0 \text{ V}; T_j = 25 \text{ °C}$	-	0.02	1	μA
I <sub>GSS</sub>	gate leakage current	$V_{DS} = 0 \text{ V}; V_{GS} = 20 \text{ V}; T_j = 25 \text{ °C}$	-	2	100	nA
		V <sub>DS</sub> = 0 V; V <sub>GS</sub> = -20 V; T <sub>j</sub> = 25 °C	-	2	100	nA
R <sub>DSon</sub>	drain-source on-state resistance	$V_{GS}$ = 10 V; $I_D$ = 25 A; $T_j$ = 175 °C; see Figure 12; see Figure 13	-	-	4.26	mΩ
		$V_{GS}$ = 10 V; $I_D$ = 25 A; $T_j$ = 25 °C; see Figure 12; see Figure 13	-	1.96	2.3	mΩ
I <sub>DSS</sub>	drain leakage current	$V_{DS} = 40 \text{ V}; V_{GS} = 0 \text{ V}; T_j = 175 \text{ °C}$	-	-	500	μΑ
Dynamic	characteristics					
Q <sub>G(tot)</sub>	total gate charge	$I_D$ = 25 A; $V_{DS}$ = 32 V; $V_{GS}$ = 10 V; see	-	175	-	nC
Q <sub>GS</sub>	gate-source charge	Figure 15	-	49	-	nC
Q <sub>GD</sub>	gate-drain charge		-	67	-	nC
V <sub>GS(pl)</sub>	gate-source plateau voltage	$I_D = 25 \text{ A}; V_{DS} = 32 \text{ V}; \text{ see } \frac{\text{Figure } 15}{15}$	-	5	-	V
C <sub>iss</sub>	input capacitance	$V_{GS} = 0 V; V_{DS} = 25 V; f = 1 MHz;$	-	8492	11323	pF
C <sub>oss</sub>	output capacitance	$T_j = 25 \text{ °C}; \text{ see } Figure 16$	-	1606	1927	pF
C <sub>rss</sub>	reverse transfer capacitance		-	1101	1508	pF
t <sub>d(on)</sub>	turn-on delay time	$V_{DS} = 30 \text{ V}; \text{ R}_{L} = 1.2 \Omega; \text{ V}_{GS} = 10 \text{ V};$	-	65	-	ns
t <sub>r</sub>	rise time	$R_{G(ext)} = 10 \Omega$	-	133	-	ns
t <sub>d(off)</sub>	turn-off delay time		-	146	-	ns
t <sub>f</sub>	fall time		-	119	-	ns
L <sub>D</sub>	internal drain inductance	from drain lead 6 mm from package to centre of die	-	4.5	-	nH
		from contact screw on mounting base to centre of die	-	3.5	-	nH
L <sub>S</sub>	internal source inductance	from source lead to source bonding pad	-	7.5	-	nH
Source-d	rain diode					
V <sub>SD</sub>	source-drain voltage	$I_S = 25 \text{ A}$ ; $V_{GS} = 0 \text{ V}$ ; $T_j = 25 \text{ °C}$ ; see Figure 14	-	0.85	1.2	V
t <sub>rr</sub>	reverse recovery time	$I_{S}$ = 20 A; $dI_{S}/dt$ = -100 A/µs; $V_{GS}$ = 0 V;	-	75	-	ns
Qr	recovered charge	$V_{DS} = 30 V$	-	57	-	nC

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Product data sheet







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## 7. Package outline

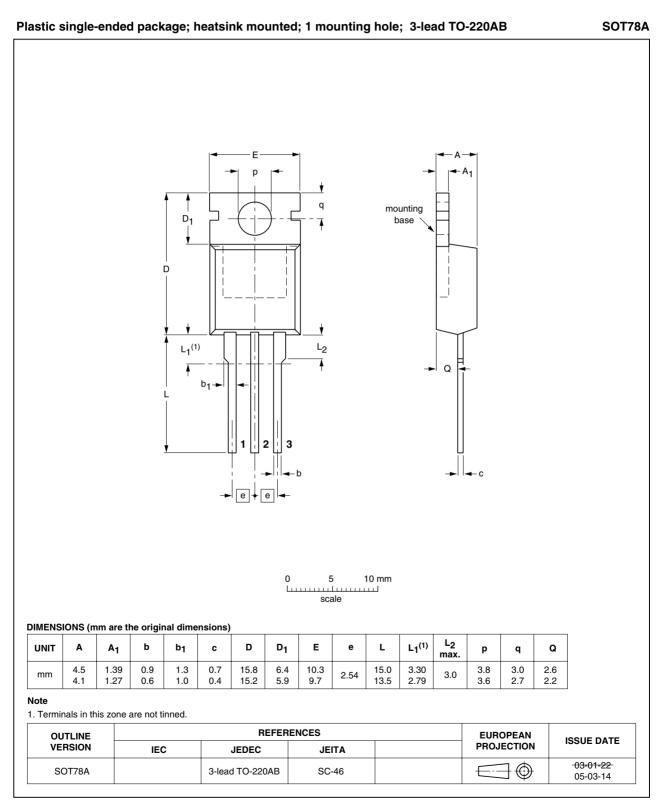


Fig 17. Package outline SOT78A (3-lead TO-220AB; SC-46; SFM3)

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Product data sheet

## 8. Revision history

Table 7. Revision hist	ory					
Document ID	Release date	Data sheet status	Change notice	Supersedes		
BUK752R3-40C_3	20090126	Product data sheet	-	BUK75_7E2R3-40C_2		
Modifications:	<ul> <li>The format of this data sheet has been redesigned to comply with the new identity guidelines of NXP Semiconductors.</li> </ul>					
	<ul> <li>Legal texts</li> </ul>	have been adapted to th	e new company name w	/here appropriate.		
	<ul> <li>Type numb</li> </ul>	er BUK752R3-40C sepa	rated from data sheet Bl	JK75_7E2R3-40C_2.		
	<ul> <li>Package or</li> </ul>	utline updated.				
BUK75_7E2R3-40C_2	20060810	Product data sheet	-	BUK75_7E2R3-40C_1		
BUK75_7E2R3-40C_1	20060503	Product data sheet	-	-		

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Document status [1][2]	Product status <sup>[3]</sup>	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
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